

# G152B

## P-CHANNEL ENHANCEMENT MODE POWER MOSFET

BV <sub>DSS</sub>	-20V
R <sub>DS(ON)</sub>	0.3Ω
I <sub>D</sub>	-0.7A

### Description

The G152B provide the designer with best combination of fast switching, low on-resistance and cost-effectiveness.

The G152B is universally preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters.

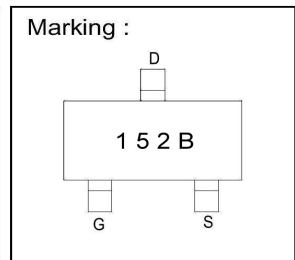
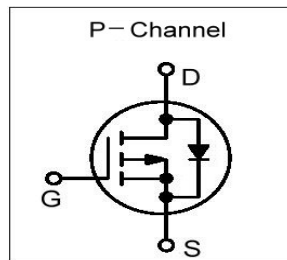
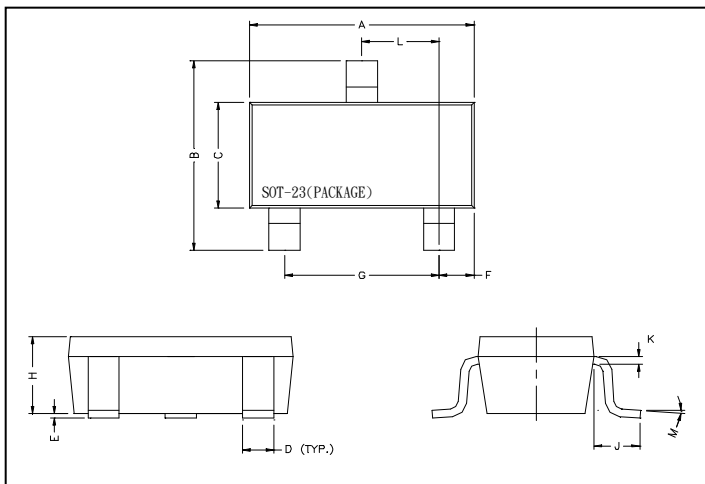
### Features

- Low On-State Resistance:0.3Ω (max)
- Ultra High Speed Switching

### Applications

- Notebook PCs
- Cellular and portable phones
- On-board power supplies
- Li-ion battery System

### Package Dimensions



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	2.70	3.10	G	1.90	REF.
B	2.40	2.80	H	1.00	1.30
C	1.40	1.60	K	0.10	0.20
D	0.35	0.50	J	0.40	-
E	0	0.10	L	0.85	1.15
F	0.45	0.55	M	0°	10°

### Absolute Maximum Ratings

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V <sub>DS</sub>	-20	V
Gate-Source Voltage	V <sub>GS</sub>	±12	V
Continuous Drain Current <sup>3</sup>	I <sub>D</sub>	-0.7	A
Pulsed Drain Current <sup>1,2</sup>	I <sub>DM</sub>	-2.8	A
Power Dissipation	P <sub>D @TA=25°C</sub>	0.5	W
Linear Derating Factor		0.01	W/°C
Operating Junction and Storage Temperature Range	T <sub>j</sub> , T <sub>stg</sub>	-55 ~ +150	°C

### Thermal Data

Parameter	Symbol	Ratings	Unit
Thermal Resistance Junction-ambient <sup>3</sup> Max.	R <sub>thj-a</sub>	90	°C/W

**Electrical Characteristics(T<sub>j</sub> = 25°C Unless otherwise specified)**

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-20	-	-	V	V <sub>GS</sub> =0, I <sub>D</sub> =-250uA
Breakdown Voltage Temperature Coefficient	$\Delta BV_{DSS} / \Delta T_j$	-	-0.1	-	V/°C	Reference to 25°C, I <sub>D</sub> =-1mA
Gate Threshold Voltage	V <sub>GS(th)</sub>	-0.5	-	-1.2	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-1mA
Forward Transconductance	g <sub>fs</sub>	-	1.5	-	S	V <sub>DS</sub> =-10V, I <sub>D</sub> =-0.4A
Gate-Source Leakage Current	I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> = ±12V
Drain-Source Leakage Current(T <sub>j</sub> =25°C)	I <sub>DSS</sub>	-	-	-10	uA	V <sub>DS</sub> =-20V, V <sub>GS</sub> =0
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>	-	135	300	mΩ	V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-0.4A
		-	192	500		V <sub>GS</sub> =-2.5V, I <sub>D</sub> =-0.4A
Total Gate Charge <sup>2</sup>	Q <sub>g</sub>	-	5.2	10	nC	I <sub>D</sub> =-0.7A V <sub>DS</sub> =-10.0V V <sub>GS</sub> =-6.0V
Gate-Source Charge	Q <sub>gs</sub>	-	1.36	-		
Gate-Drain ("Miller") Change	Q <sub>gd</sub>	-	0.6	-		
Turn-on Delay Time <sup>2</sup>	T <sub>d(on)</sub>	-	5	-	ns	V <sub>DD</sub> =-10V I <sub>D</sub> =-0.4A V <sub>GS</sub> =-5V
Rise Time	T <sub>r</sub>	-	20	-		
Turn-off Delay Time	T <sub>d(off)</sub>	-	55	-		
Fall Time	T <sub>f</sub>	-	70	-		
Input Capacitance	C <sub>iss</sub>	-	180	-	pF	V <sub>GS</sub> =0V V <sub>DS</sub> =-10V f=1.0MHz
Output Capacitance	C <sub>oss</sub>	-	120	-		
Reverse Transfer Capacitance	C <sub>rss</sub>	-	60	-		

**Source-Drain Diode**

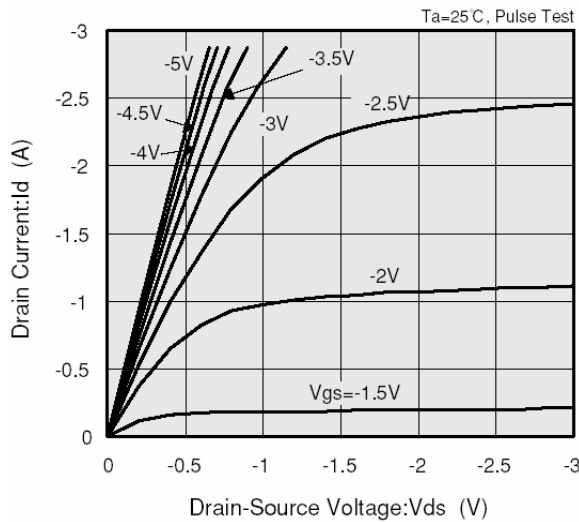
Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Forward On Voltage <sup>2</sup>	V <sub>SD</sub>	-	-	-1.1	V	I <sub>S</sub> =-0.7A, V <sub>GS</sub> =0V

Notes: 1. Pulse width limited by Max. junction temperature.

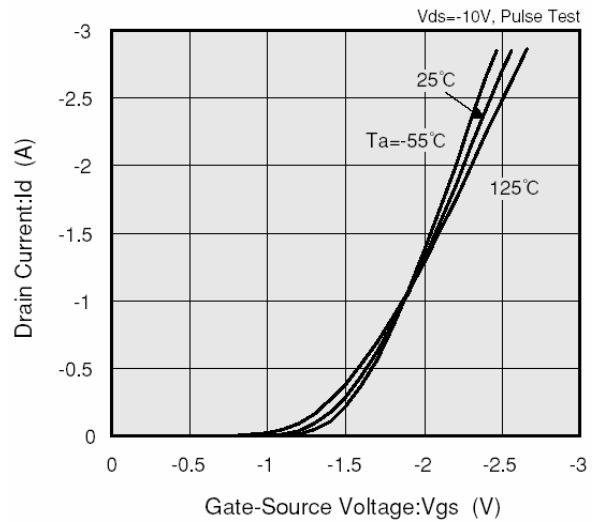
2. Pulse width ≤ 300us, duty cycle ≤ 2%.

3. Surface mounted on 1 in<sup>2</sup> copper pad of FR4 board;270°C/W when mounted on min. copper pad.

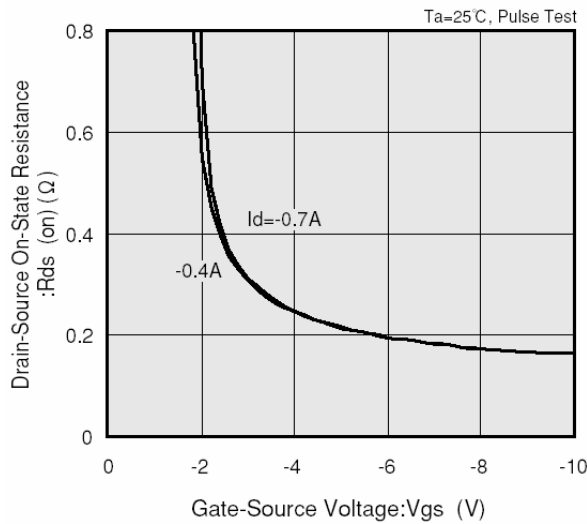
## Characteristics Curve



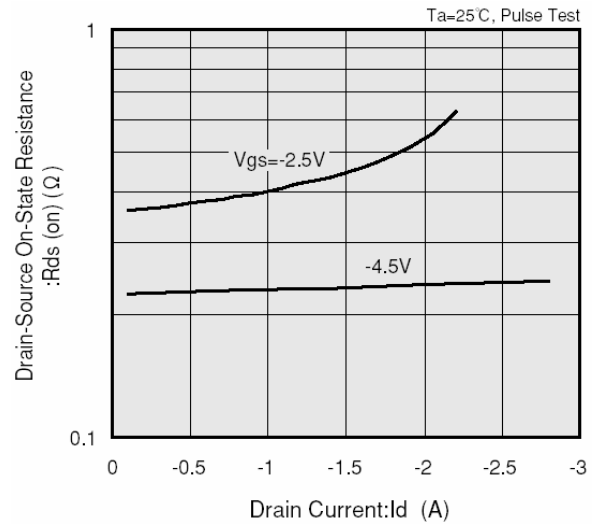
**Fig 1. Drain Current vs. Drain-Source Voltage**



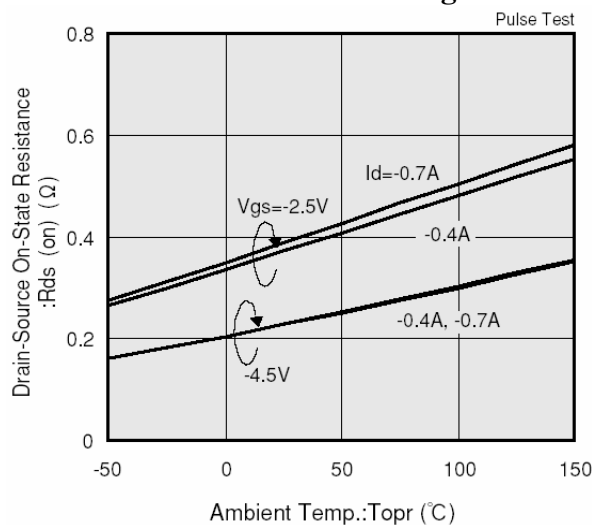
**Fig 2. Drain Current vs. Gate-Source Voltage**



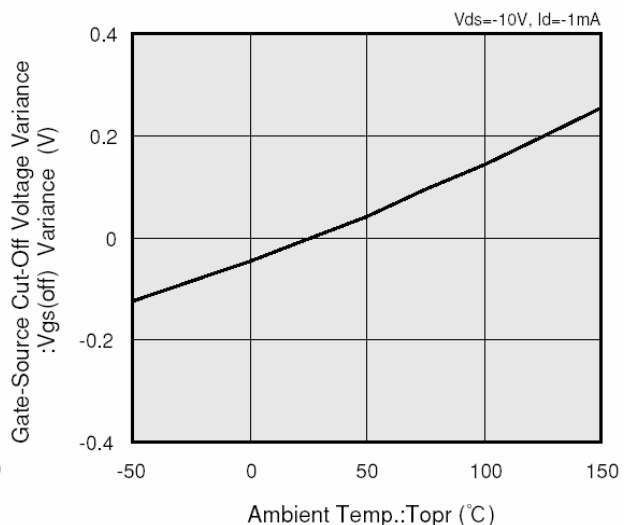
**Fig 3. Drain-Source On-State Resistance vs. Gate-Source Voltage**



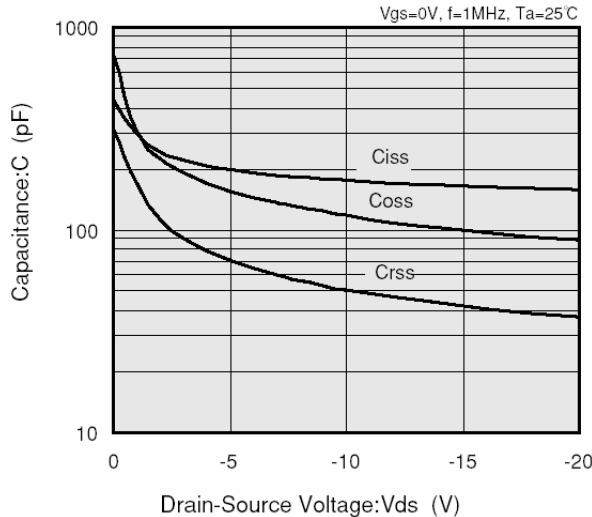
**Fig 4. Drain-Source On-State Resistance vs. Drain Current**



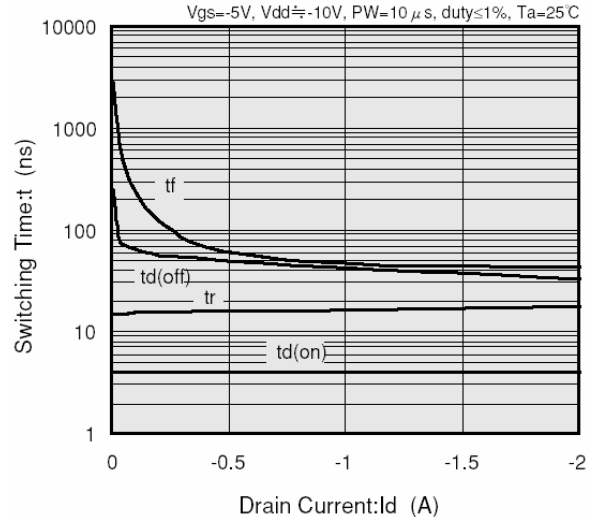
**Fig 5. Drain-Source On-State Resistance vs. Ambient Temperature**



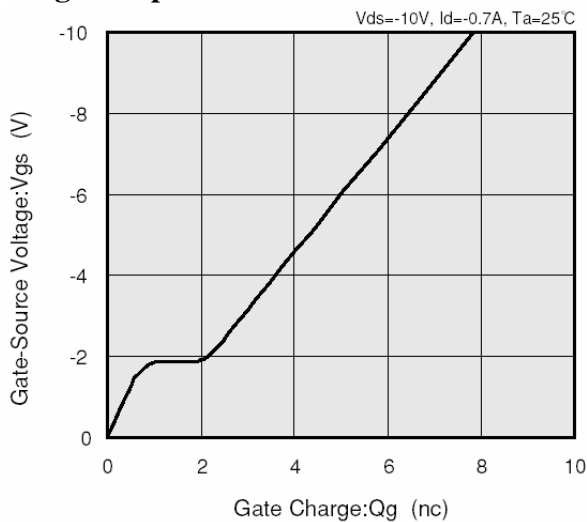
**Fig 6. Gate-Source Cut-off Voltage Variance vs. Ambient Temperature**



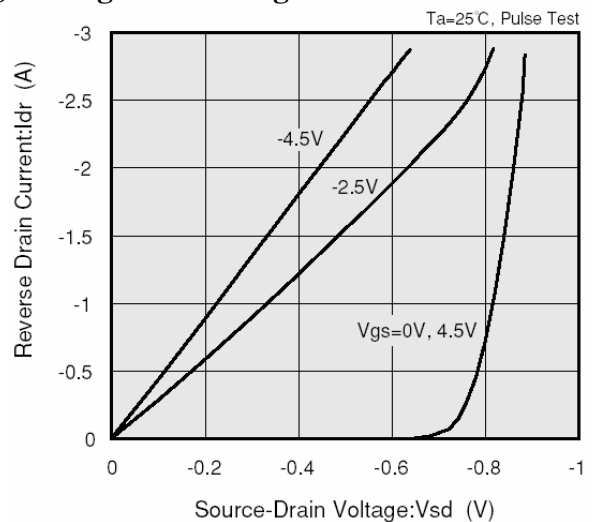
**Fig 7. Capacitance v.s. Drain-Source Voltage**



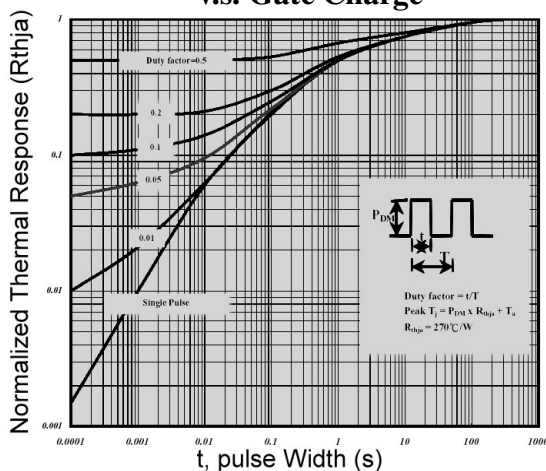
**Fig 8. Switching Time v.s. Drain Current**



**Fig 9. Gate-Source Voltage v.s. Gate Charge**



**Fig 10. Reverse Drain-Current v.s. Source-Drain Voltage**



**Fig 11. Thermal Resistance v.s. Pulse Width**

**Important Notice:**

- All rights are reserved. Reproduction in whole or in part is prohibited without the prior written approval of GTM.
- GTM reserves the right to make changes to its products without notice.
- GTM semiconductor products are not warranted to be suitable for use in life-support Applications, or systems.
- GTM assumes no liability for any consequence of customer product design, infringement of patents, or application assistance.

**Head Office And Factory:**

- Taiwan:** No. 17-1 Tatung Rd. Fu Kou Hsin-Chu Industrial Park, Hsin-Chu, Taiwan, R. O. C.
- TEL : 886-3-597-7061 FAX : 886-3-597-9220, 597-0785
- China:** (201203) No.255, Jang-Jiang Tsai-Lueng RD. , Pu-Dung-Hsin District, Shang-Hai City, China
- TEL : 86-21-5895-7671 ~ 4 FAX : 86-21-38950165